

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
209252US0SERIAL NO.
NEW APPLICATION

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Yoshiyuki ASAYAMA, et al.

FILING DATE

HEREWITH

GROUP

1772

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>pln</i>	AA	4,721,500	01/26/88	Gerald J. VAN HANDEL, et al.	493	152	
<i>pln</i>	AB	4,609,140	09/02/86	Gerald J. VAN HANDEL, et al.	229	2.5	
<i>pln</i>	AC	4,026,458	05/31/77	Jerald A. MORRIS, et al.	225	14	
<i>pln</i>	AD	6,066,375	05/23/00	Kenneth J. SHANTON	428	35.7	
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO
	AO					
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

Examiner

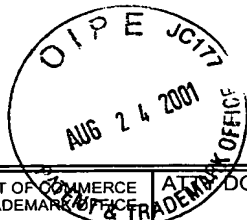
Patricia J. Nordmeys

Date Considered

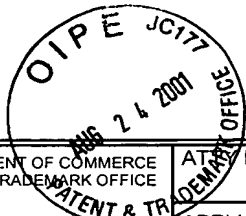
7/22/02

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1903 U.S. P.T.O.
09/86/629
05/31/01



Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTORNEY DOCKET NO. 209252US0	SERIAL NO. 09/867,629				
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Yoshiyuki ASAYAMA, et al.					
		FILING DATE May 31, 2001	GROUP 1772				
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
pln	AA	2,997,927	08/29/61	R. H. CARSON	93	36	
pln	AB	3,033,434	05/08/62	R. H. CARSON	229	452.5	
pln	AC	3,468,468	09/23/69	J. E. FOOTE	229	14	
pln	AD	3,932,575	01/13/76	S. I. ANDERSSON	264	154	
pln	AE	4,026,458	05/31/77	J. A. MORRIS, et al.	229	14	
pln	AF	4,313,899	02/02/82	P. HAIN	264	40.1	
pln	AG	4,381,278	04/26/83	D. D. INGRAFFEA	264	512	
pln	AH	4,381,909	05/03/83	D. D. INGRAFFEA	425	387.1	
pln	AI	4,086,316	04/25/78	K. AHRWEILER, et al.	264	120	
pln	AJ	4,576,566	03/18/86	P. O. HAIN	425	400	
pln	AK	4,595,611	06/17/86	J. R. QUICK, et al.	428	35	
pln	AL	4,606,496	08/19/86	R. P. MARX, et al.	229	2.5	
pln	AM	4,637,811	01/20/87	J. L. FORTNEY	493	167	
pln	AN	5,078,939	01/07/92	T. KATSURA, et al.	264	137	
pln	AO	5,083,699	01/28/92	D. J. BULCHER	229	2.5	
pln	AP	5,203,491	04/20/93	R. P. MARX, et al.	229	2.5	
pln	AQ	5,938,112	08/17/99	E. R. SANDSTROM	229	407	
pln	AR	4,609,140	09/02/86	G. J. VAN HANDEL, et al.	229	2.5	
pln	AS	4,721,500	01/26/88	G. J. VAN HANDEL, et al.	493	152	
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Examiner <i>Patricia L. Nordmeyer</i>					Date Considered <i>7/22/02</i>		
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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yoshiyuki ASAYAMA, et al.			
				FILING DATE May 31, 2001		GROUP 1772	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
pln	BA	53-10622	04/14/78	JAPAN (with English Abstract)			X
pln	BB	55-30456	08/11/80	JAPAN (with English Abstract)			X
pln	BC	56-48300	11/14/81	JAPAN (with English Abstract)			X
pln	BD	4-36935	06/17/92	JAPAN (with English Abstract)			X
pln	BE	2513091	04/30/96	JAPAN (with English Abstract)			X
pln	BF	2796646	07/03/98	JAPAN (with English Abstract)			X
pln	BG	2875496	01/14/99	JAPAN (with English Abstract)			X
pln	BH	3082015	06/30/2000	JAPAN (with English Abstract)			X
pln	BI	59-500701	04/26/84	JAPAN (with English Abstract and corr. US 4,609,140 and US 4,721,500)			X
pln	BJ	53-6178	01/20/78	JAPAN			X
pln	BK	58-56841	04/04/83	JAPAN			X
pln	BL	58-186698	10/31/83	JAPAN (with English Abstract)			X
pln	BM	60-73838	04/26/85	JAPAN (with English Abstract)			X
pln	BN	62-182032	08/10/87	JAPAN (with English Abstract)			X
pln	BO	63-176130	07/20/88	JAPAN (with English Abstract)			X
pln	BP	63-268630	11/07/88	JAPAN			X
pln	BQ	2-88235	03/28/90	JAPAN (with English Abstract)			X
pln	BR	5-192239	08/03/93	JAPAN (with English Abstract)			X
pln	BS	5-286023	11/02/93	JAPAN (with English Abstract)			X
pln	BT	6-134898	05/17/94	JAPAN (with English Abstract)			X
pln	BU	6-219424	08/09/94	JAPAN (with English Abstract)			X
pln	BV	6-239334	08/30/94	JAPAN (with English Abstract)			X
pln	BW	6-329142	11/29/94	JAPAN (with English Abstract)			X
pln	BX	7-214705	08/15/95	JAPAN (with English Abstract)			X
pln	BY	7-242224	09/19/95	JAPAN (with English Abstract)			X
pln	BZ	7-315358	12/05/95	JAPAN (with English Abstract)			X
Examiner <i>Patricia J. Nadmeyer</i>					Date Considered <i>7/22/02</i>		
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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTACHMENT NO. 209252US0		SERIAL NO. 09/867,629	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yoshiyuki ASAYAMA, et al.			
				FILING DATE May 31, 2001		GROUP 1772	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
pln	CA	8-13400	01/16/96	JAPAN (with English Abstract)			X
pln	CB	8-113227	05/07/96	JAPAN (with English Abstract)			X
pln	CC	9-142432	06/03/97	JAPAN (with English Abstract)			X
pln	CD	10-8393	01/13/98	JAPAN (with English Abstract)			X
pln	CE	10-8394	01/13/98	JAPAN (with English Abstract)			X
pln	CF	10-16144	01/20/98	JAPAN (with English Abstract)			X
pln	CG	10-43027	02/17/98	JAPAN (with English Abstract)			X
pln	CH	10-71656	03/17/98	JAPAN (with English Abstract)			X
pln	CI	10-175626	06/30/98	JAPAN (with English Abstract)			X
pln	CJ	10-291247	11/04/98	JAPAN (with English Abstract)			X
pln	CK	11-165725	06/22/99	JAPAN (with English Abstract)			X
pln	CL	11-240111	09/07/99	JAPAN (with English Abstract)			X
pln	CM	11-334715	12/07/99	JAPAN (with English Abstract)			X
pln	CN	2000-33927	02/02/2000	JAPAN (with English Abstract)			X
pln	CO	2000-203554	07/25/2000	JAPAN (with English Abstract)			X
pln	CP	2000-211045	08/02/2000	JAPAN (with English Abstract)			X
pln	CQ	2000-229619	08/22/2000	JAPAN (with English Abstract)			X
pln	CR	2000-238861	09/05/2000	JAPAN (with English Abstract)			X
pln	CS	3035868	01/16/97	JAPAN			X
pln	CT	3042846	08/13/97	JAPAN			X
pln	CU	3042847	08/13/97	JAPAN			X
pln	CV	2604577	03/10/2000	JAPAN			X
pln	CW	54-40884	12/01/79	JAPAN			X
pln	CX	58-37771	08/26/83	JAPAN			X
pln	CY	61-14437	05/06/86	JAPAN			X
	CZ						
Examiner <i>Patricia J. Nordmeyer</i>					Date Considered <i>7/22/02</i>		
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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 210689US3PCT		SERIAL NO. 09/868,916	
<div style="position: relative; width: 100px; height: 100px; margin: auto;"> <div style="position: absolute; top: 0; left: 0; width: 100%; height: 100%; border: 1px solid black; border-radius: 50%; text-align: center; line-height: 100px;"> OIPF JAN 18 2002 PATENT & TRADEMARK OFFICE 6825 </div> </div>				APPLICANT Kazue WATANABE			
				FILING DATE July 11, 2001		GROUP 1772	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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	AB						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
pln	AO	4-317519	11/09/92	JAPAN (with English Abstract)			X
pln	AP	9-109600	04/28/97	JAPAN (with English Abstract)			X
pln	AQ	6-298441	10/25/94	JAPAN (with English Abstract)			X
pln	AR	40-22268	10/02/65	JAPAN (we will submit a copy at a later date)			
	AS						
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	AU						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
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Examiner <i>Patricia L. Nordmeyer</i>					Date Considered 7/22/02		

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